Se	Search Notes			
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/722,217	FANG, JIAFU
Examiner	Art Unit
Erma Cameron	1762

SEARCHED				
Class	Subclass	Date	Examiner	
				
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH N (INCLUDING SEARC)
	DATE	EXMR
EIC search	2/9/2007	ECC
427/393.5	3/3/2007	ECC